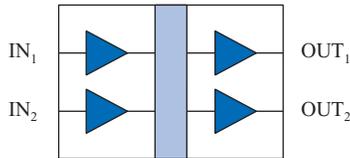
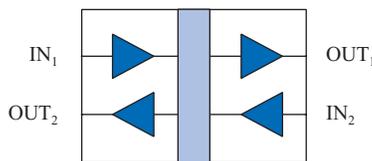


High Speed/High Temperature Dual Digital Isolators

Functional Diagrams



IL711



IL712

Features

- +5 V/+3.3 V CMOS / TTL Compatible
- High Speed: 150 Mbps Typical (IL711S/IL712S)
- High Temperature: -40°C to +125°C (IL711T/IL712T)
- 2500 V_{RMS} Isolation (1 min.)
- 300 ps Typical Pulse Width Distortion (IL711S/IL712S)
- 4 ns Typical Propagation Delay Skew
- 10 ns Typical Propagation Delay
- 30 kV/μs Typical Common Mode Transient Immunity
- 2 ns Channel-to-Channel Skew
- 8-pin MSOP, SOIC, and PDIP Packages
- UL1577 and IEC 61010-2001 Approval

Applications

- ADCs and DACs
- Digital Fieldbus
- RS-485 and RS-422
- Multiplexed Data Transmission
- Data Interfaces
- Board-to-Board Communication
- Digital Noise Reduction
- Operator Interface
- Ground Loop Elimination
- Peripheral Interfaces
- Serial Communication
- Logic Level Shifting

Description

NVE's IL700 family of high-speed digital isolators are CMOS devices manufactured with NVE's patented* IsoLoop[®] spintronic Giant Magnetoresistive (GMR) technology. The IL711S and IL712S are the world's fastest two-channel isolators, with a 150 Mbps typical data rate for both channels.

The symmetric magnetic coupling barrier provides a typical propagation delay of only 10 ns and a pulse width distortion as low as 300 ps (0.3 ns), achieving the best specifications of any isolator. Typical transient immunity of 30 kV/μs is unsurpassed. The IL711 has two transmit channels; the IL712 has one transmit and one receive channel. The IL712 operates full duplex, making it ideal for many fieldbus applications, including PROFIBUS.

The IL711 and IL712 are available in 8-pin MSOP, SOIC, and PDIP packages. Standard and S-Grade parts are specified over a temperature range of -40°C to +100°C; T-Grade parts are specified over a temperature range of -40°C to +125°C.

Absolute Maximum Ratings

Parameters	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Storage Temperature	T_s	-55		150	°C	
Ambient Operating Temperature ⁽¹⁾ IL711T/IL712T	T_A	-55		125 135	°C	
Supply Voltage	V_{DD1}, V_{DD2}	-0.5		7	V	
Input Voltage	V_i	-0.5		$V_{DD} + 0.5$	V	
Output Voltage	V_o	-0.5		$V_{DD} + 0.5$	V	
Output Current Drive	I_o			10	mA	
Lead Solder Temperature				260	°C	10 sec.
ESD			2		kV	HBM

Recommended Operating Conditions

Parameters	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Ambient Operating Temperature IL711/IL712 and IL711S/IL712S IL711T/IL712T	T_A	-40 -40		100 125	°C °C	
Supply Voltage	V_{DD1}, V_{DD2}	3.0		5.5	V	
Logic High Input Voltage	V_{IH}	2.4		V_{DD}	V	
Logic Low Input Voltage	V_{IL}	0		0.8	V	
Input Signal Rise and Fall Times	t_{IR}, t_{IF}			1	µs	

Insulation Specifications

Parameters	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Creepage Distance						
MSOP		3.01			mm	
SOIC		4.03			mm	
PDIP		7.04			mm	
Leakage Current			0.2		µA	240 V_{RMS} , 60 Hz
Barrier Impedance			$>10^{14} 3$		ΩpF	

Package Characteristics

Parameters	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Capacitance (Input–Output) ⁽⁵⁾	C_{I-O}		2		pF	f = 1 MHz
Thermal Resistance						
MSOP	θ_{JC}		168		°C/W	Thermocouple at center underside of package
SOIC	θ_{JC}		144		°C/W	
PDIP	θ_{JC}		54		°C/W	
Package Power Dissipation	P_{PD}			150	mW	f = 1 MHz, $V_{DD} = 5 V$

Safety and Approvals

IEC61010-1

TUV Certificate Numbers: N1502812, N1502812-101

Classification as Reinforced Insulation

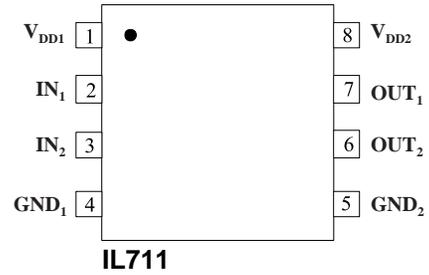
Model	Package	Pollution Degree	Material Group	Max. Working Voltage
IL711-1; IL712-1	MSOP		Pending Approval	
IL711-2; IL712-2	PDIP	II	III	300 V_{RMS}
IL711-3; IL712-3	SOIC	II	III	150 V_{RMS}

UL 1577

Component Recognition Program File Number: E207481
Rated 2500 V_{RMS} for 1 minute

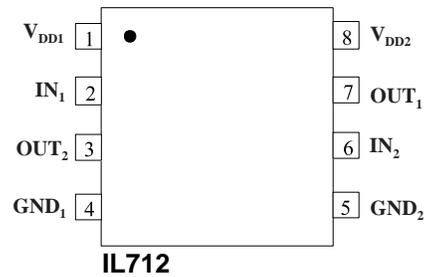
IL711 Pin Connections

1	V _{DD1}	Supply voltage
2	IN ₁	Data in, channel 1
3	IN ₂	Data in, channel 2
4	GND ₁	Ground return for V _{DD1}
5	GND ₂	Ground return for V _{DD2}
6	OUT ₂	Data out, channel 2
7	OUT ₁	Data out, channel 1
8	V _{DD2}	Supply voltage

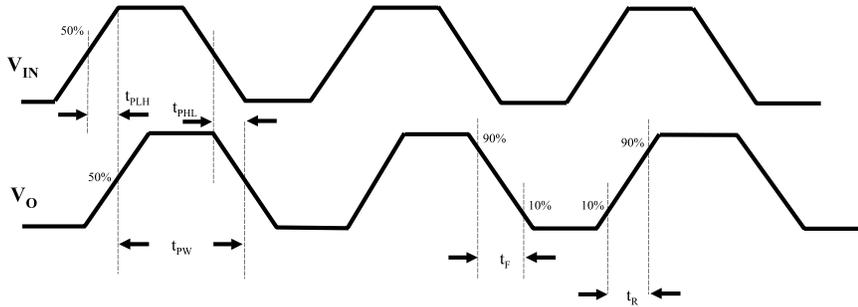


IL712 Pin Connections

1	V _{DD1}	Supply voltage
2	IN ₁	Data in, channel 1
3	OUT ₂	Data out, channel 2
4	GND ₁	Ground return for V _{DD1}
5	GND ₂	Ground return for V _{DD2}
6	IN ₂	Data in, channel 2
7	OUT ₁	Data out, channel 1
8	V _{DD2}	Supply voltage



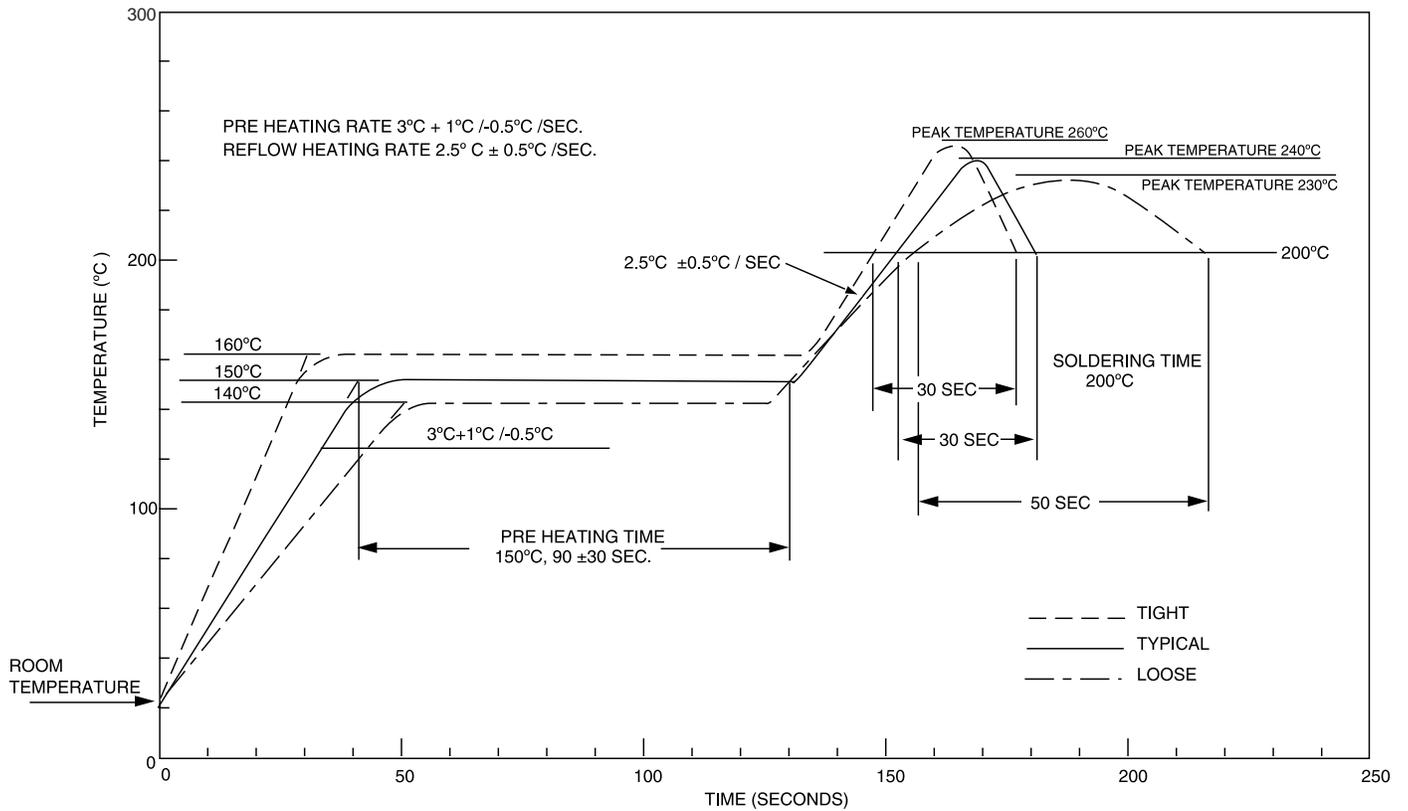
Timing Diagram



Legend

t_{PLH}	Propagation Delay, Low to High
t_{PHL}	Propagation Delay, High to Low
t_{pw}	Minimum Pulse Width
t_r	Rise Time
t_f	Fall Time

IR Soldering Profile



3.3 Volt Electrical Specifications

Electrical specifications are T_{min} to T_{max} unless otherwise stated.

Parameters	Symbol	Min.	Typ.	Max.	Units	Test Conditions
DC Specifications						
Input Quiescent Supply Current						
IL711	I_{DD1}		8	10	μA	
IL712			1.5	2	mA	
Output Quiescent Supply Current						
IL711	I_{DD2}		3.3	4	mA	
IL712				1.5	2	mA
Logic Input Current	I_I	-10		10	μA	
Logic High Output Voltage	V_{OH}	$V_{DD} - 0.1$	V_{DD}		V	$I_O = -20 \mu\text{A}, V_I = V_{IH}$
		$0.8 \times V_{DD}$	$0.9 \times V_{DD}$			$I_O = -4 \text{mA}, V_I = V_{IH}$
Logic Low Output Voltage	V_{OL}		0	0.1	V	$I_O = 20 \mu\text{A}, V_I = V_{IL}$
				0.5	0.8	
Switching Specifications						
Maximum Data Rate					Mbps	$C_L = 15 \text{pF}$
IL711/IL712 and IL711T/IL712T		100	110			
IL711S and IL712S		130	140		Mbps	$C_L = 15 \text{pF}$
Pulse Width ⁽⁷⁾	PW	10	7.5		ns	50% Points, V_O
Propagation Delay Input to Output (High to Low)	t_{PHL}		12	18	ns	$C_L = 15 \text{pF}$
Propagation Delay Input to Output (Low to High)	t_{PLH}		12	18	ns	$C_L = 15 \text{pF}$
Pulse Width Distortion ⁽²⁾	PWD		2	3	ns	$C_L = 15 \text{pF}$
IL711/IL712 and IL711T/IL712T			1	3		
IL711S and IL712S						
Propagation Delay Skew ⁽³⁾	t_{PSK}		4	6	ns	$C_L = 15 \text{pF}$
Output Rise Time (10%–90%)	t_R		2	4	ns	$C_L = 15 \text{pF}$
Output Fall Time (10%–90%)	t_F		2	4	ns	$C_L = 15 \text{pF}$
Common Mode Transient Immunity (Output Logic High or Logic Low) ⁽⁴⁾	$ CM_H , CM_L $	20	30		$\text{kV}/\mu\text{s}$	$V_{CM} = 300 \text{V}$
Channel-to-Channel Skew	t_{CSK}		2	3	ns	$C_L = 15 \text{pF}$
Dynamic Power Consumption ⁽⁶⁾			140	240	$\mu\text{A}/\text{MHz}$	per channel

5 Volt Electrical Specifications

Electrical specifications are T_{min} to T_{max} unless otherwise stated.

Parameters	Symbol	Min.	Typ.	Max.	Units	Test Conditions
DC Specifications						
Input Quiescent Supply Current						
IL711	I_{DD1}		10	15	μA	
IL712			2.5	3	mA	
Output Quiescent Supply Current						
IL711	I_{DD2}		5	6	mA	
IL712			2.5	3	mA	
Logic Input Current	I_I	-10		10	μA	
Logic High Output Voltage	V_{OH}	$V_{DD} - 0.1$	V_{DD}		V	$I_O = -20 \mu\text{A}, V_I = V_{IH}$
		$0.8 \times V_{DD}$	$0.9 \times V_{DD}$			$I_O = -4 \text{mA}, V_I = V_{IH}$
Logic Low Output Voltage	V_{OL}		0	0.1	V	$I_O = 20 \mu\text{A}, V_I = V_{IL}$
				0.5	0.8	
Switching Specifications						
Maximum Data Rate IL711/IL712 and IL711T/IL712T IL711S and IL712S		100 130	110 150		Mbps Mbps	$C_L = 15 \text{pF}$ $C_L = 15 \text{pF}$
Pulse Width ⁽⁷⁾	PW	10	7.5		ns	50% Points, V_o
Propagation Delay Input to Output (High to Low)	t_{PHL}		10	15	ns	$C_L = 15 \text{pF}$
Propagation Delay Input to Output (Low to High)	t_{PLH}		10	15	ns	$C_L = 15 \text{pF}$
Pulse Width Distortion ⁽²⁾ IL711/IL712 and IL711T/IL712T IL711S and IL712S	PWD		2 0.3	3 3	ns	$C_L = 15 \text{pF}$
Propagation Delay Skew ⁽³⁾	t_{PSK}		4	6	ns	$C_L = 15 \text{pF}$
Output Rise Time (10%–90%)	t_R		1	3	ns	$C_L = 15 \text{pF}$
Output Fall Time (10%–90%)	t_F		1	3	ns	$C_L = 15 \text{pF}$
Common Mode Transient Immunity (Output Logic High or Logic Low) ⁽⁴⁾	$ CM_H , CM_L $	20	30		$\text{kV}/\mu\text{s}$	$V_{cm} = 300 \text{V}$
Channel to Channel Skew	t_{CSK}		2	3	ns	$C_L = 15 \text{pF}$
Dynamic Power Consumption ⁽⁶⁾			200	340	$\mu\text{A}/\text{MHz}$	per channel

Notes (apply to both 3.3 V and 5 V specifications):

- Absolute maximum ambient operating temperature means the device will not be damaged if operated under these conditions. It does not guarantee performance.
- PWD is defined as $|t_{PHL} - t_{PLH}|$. %PWD is equal to PWD divided by pulse width.
- t_{PSK} is the magnitude of the worst-case difference in t_{PHL} and/or t_{PLH} between devices at 25°C.
- CM_H is the maximum common mode voltage slew rate that can be sustained while maintaining $V_o > 0.8 V_{DD2}$. CM_L is the maximum common mode input voltage that can be sustained while maintaining $V_o < 0.8 \text{V}$. The common mode voltage slew rates apply to both rising and falling common mode voltage edges.
- Device is considered a two terminal device: pins 1–4 shorted and pins 5–8 shorted.
- Dynamic power consumption is calculated per channel and is supplied by the channel's input side power supply.
- Minimum pulse width is the minimum value at which specified PWD is guaranteed.

Electrostatic Discharge Sensitivity

This product has been tested for electrostatic sensitivity to the limits stated in the specifications. However, NVE recommends that all integrated circuits be handled with appropriate care to avoid damage. Damage caused by inappropriate handling or storage could range from performance degradation to complete failure.

Application Information

Dynamic Power Consumption

IsoLoop Isolators achieve their low power consumption from the way they transmit data across the isolation barrier. By detecting the edge transitions of the input logic signal and converting these to narrow current pulses, a magnetic field is created around the GMR Wheatstone bridge. Depending on the direction of the magnetic field, the bridge causes the output comparator to switch following the input logic signal. Since the current pulses are narrow, about 2.5 ns, the power consumption is independent of mark-to-space ratio and solely dependent on frequency. This has obvious advantages over optocouplers, which have power consumption heavily dependent on mark-to-space ratio.

Power Supply Decoupling

Both power supplies to these devices should be decoupled with low ESR 47 nF ceramic capacitors. Ground planes for both GND₁ and GND₂ are highly recommended for data rates above 10 Mbps. Capacitors must be located as close as possible to the V_{DD} pins.

Signal Status on Start-up and Shut Down

To minimize power dissipation, input signals are differentiated and then latched on the output side of the isolation barrier to reconstruct the signal. This could result in an ambiguous output state depending on power up, shutdown and power loss sequencing. Therefore, the designer should consider including an initialization signal in the start-up circuit. Initialization consists of toggling the input either high then low, or low then high.

Data Transmission Rates

The reliability of a transmission system is directly related to the accuracy and quality of the transmitted digital information. For a digital system, those parameters which determine the limits of the data transmission are pulse width distortion and propagation delay skew.

Propagation delay is the time taken for the signal to travel through the device. This is usually different when sending a low-to-high than when sending a high-to-low signal. This difference, or error, is called pulse width distortion (PWD) and is usually in nanoseconds. It may also be expressed as a percentage:

$$\text{PWD}\% = \frac{\text{Maximum Pulse Width Distortion (ns)}}{\text{Signal Pulse Width (ns)}} \times 100\%$$

For example, with data rates of 12.5 Mbps:

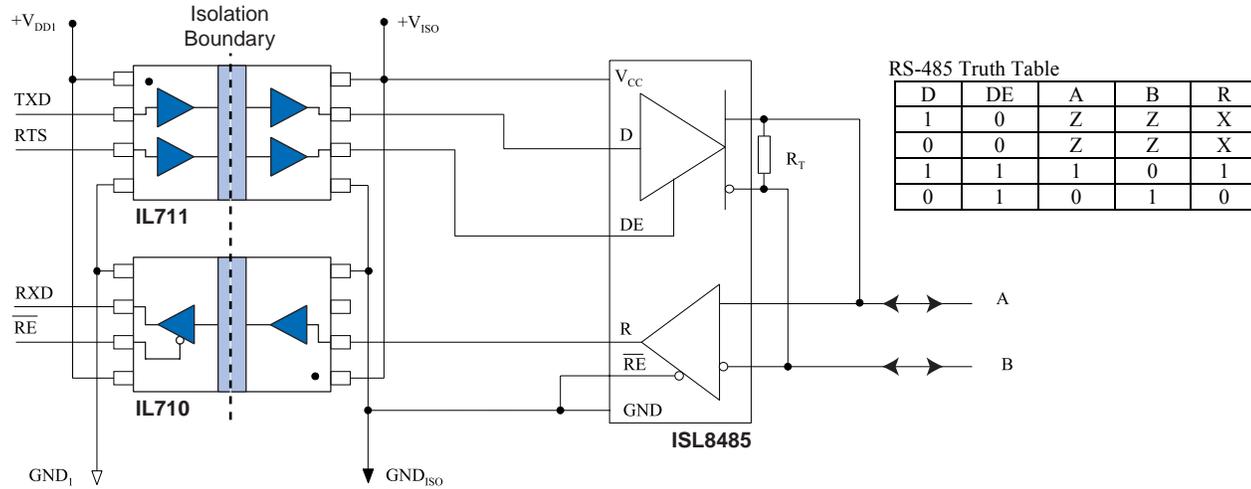
$$\text{PWD}\% = \frac{3 \text{ ns}}{80 \text{ ns}} \times 100\% = 3.75\%$$

This figure is almost **three times** better than any available optocoupler with the same temperature range, and **two times** better than any optocoupler regardless of published temperature range. IsoLoop isolators exceed the 10% maximum PWD recommended by PROFIBUS, and will run to nearly 35 Mb within the 10% limit.

Propagation delay skew is the signal propagation difference between two or more channels. This becomes significant in clocked systems because it is undesirable for the clock pulse to arrive before the data has settled. Short propagation delay skew is therefore especially critical in high data rate parallel systems for establishing and maintaining accuracy and repeatability. Worst-case channel-to-channel skew in an IL700 Isolator is only 3 ns, which is **ten times** better than any optocoupler. IL700 Isolators have a maximum propagation delay skew of 6 ns, which is **five times** better than any optocoupler.

Application Diagrams

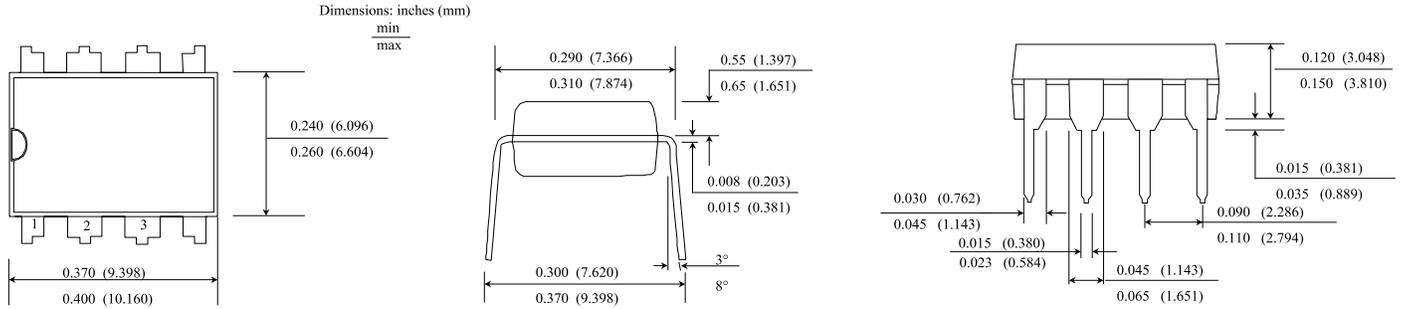
Isolated PROFIBUS / RS-485



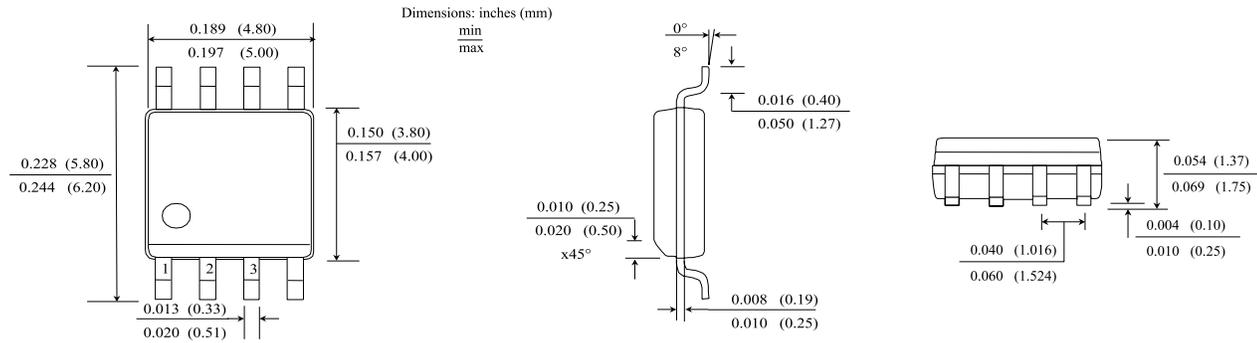
NVE offers a unique line of PROFIBUS / RS-485 transceivers, but IL700 high-speed digital signal isolators can also be used as part of multi-chip designs using non-isolated PROFIBUS transceivers.

Package Drawings, Dimensions and Specifications

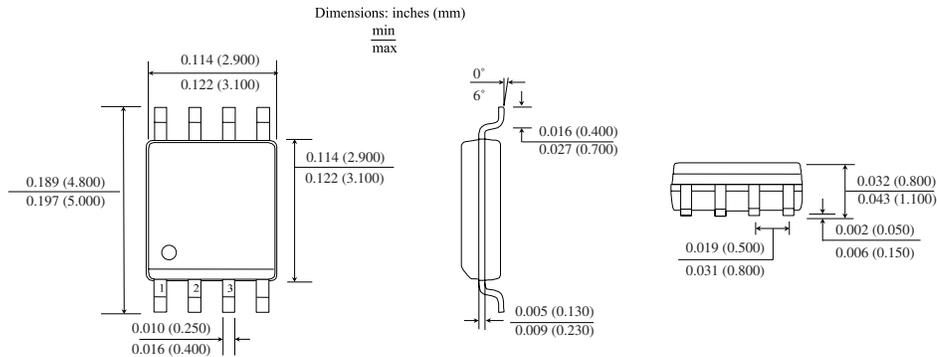
8-pin PDIP



8-pin SOIC Package

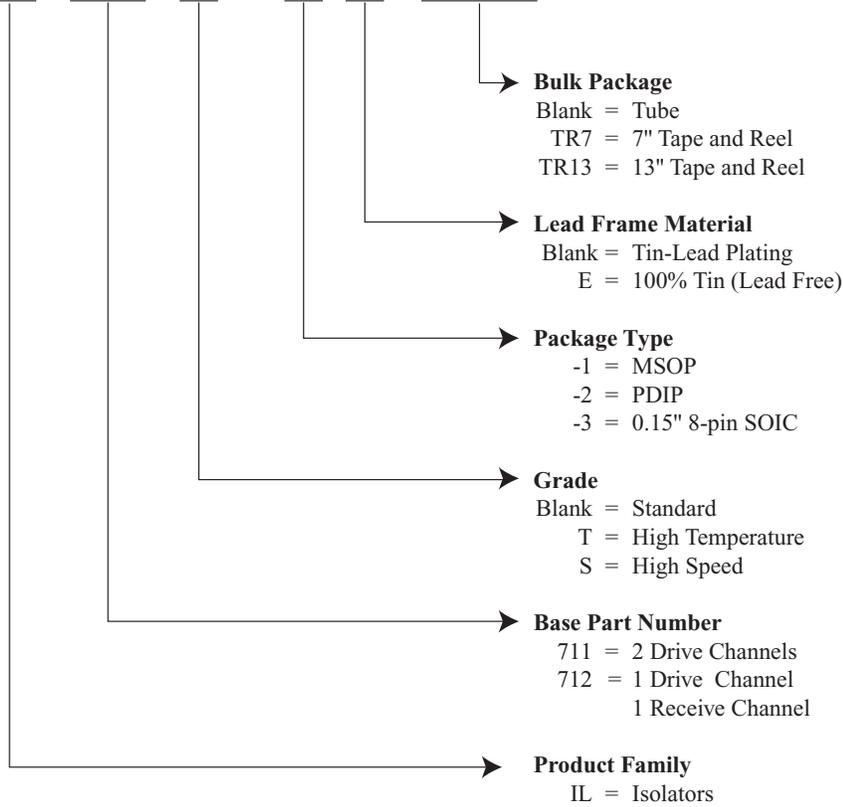


8-pin MSOP



Ordering Information and Valid Part Numbers

IL 711 T - 3 E TR13



Valid Part Numbers

IL711-1	IL712-1
IL711-1E	IL712-1E
IL711S-1	IL712S-1
IL711S-1E	IL712S-1E
IL711T-1	IL712T-1
IL711T-1E	IL712T-1E

IL711-2	IL712-2
IL711-2E	IL712-2E
IL711T-2	IL712T-2
IL711T-2E	IL712T-2E

IL711-3	IL712-3
IL711S-3	IL712S-3
IL711T-3	IL712T-3
IL711-3E	IL712-3E
IL711S-3E	IL712S-3E
IL711T-3E	IL712T-3E

All MSOP and SOIC parts are available on tape and reel.

All MSOP and SOIC parts are available on tape and reel.

ISB-DS-001-IL711/12-K
January 2007

ISB-DS-001-IL711/12-J

ISB-DS-001-IL711/12-I

ISB-DS-001-IL711/12-H

Changes

- Added RS-485 application circuit

Changes

- MSOP packages, S- and T-Grades added
- Order information updated

Changes

Added MSOP Specifications

Updated IEC and UL Approval Numbers

Changes

Page 1: Revision letter added.

Page 1: T-Series parts temperature information added.

Page 2: T-Series parts temperature information added to Absolute Maximum Ratings.

Page 2: T-Series parts temperature information added to Recommending Operating Conditions.

Page 2: Storage temperature changed from 175°C max. to 150°C max.

Page 2: Lead soldering temperature changed from 180°C max. to 260°C max.

Page 2: Package Power Dissipation: Test Condition added $f = 1\text{MHz}$, $V_{DD} = 5\text{V}$.

Page 2: IEC 61010-1 Classification: "Reinforced Insulation" added.

Page 9: Ordering Information: Temperature Range Option added

Page 9: Ordering Information: 5 Volt only option removed.

Valid Part Numbers IL711-2B, IL711-3B, IL711-2BE,

IL711-3BE, IL712-2B, IL712-3B,

IL712-2BE, and IL712-3BE removed.

About NVE

An ISO 9001 Certified Company

NVE Corporation manufactures innovative products based on unique spintronic Giant Magnetoresistive (GMR) technology. Products include Magnetic Field Sensors, Magnetic Field Gradient Sensors (Gradiometers), Digital Magnetic Field Sensors, Digital Signal Isolators, and Isolated Bus Transceivers.

NVE pioneered spintronics and in 1994 introduced the world's first products using GMR material, a line of ultra-precise magnetic sensors for position, magnetic media, gear speed and current sensing.

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ISB-DS-001-IL711/12-K
January 2007